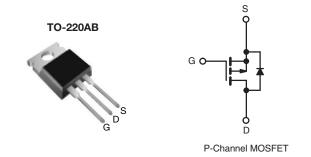


## **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	- 100			
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = - 10 V 0.30			
Q <sub>g</sub> (Max.) (nC)	38			
Q <sub>gs</sub> (nC)	6.8			
Q <sub>gd</sub> (nC)	21			
Configuration	Single			



### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION		
Package	TO-220AB	
Lead (Pb)-free	IRF9530PbF	
Leau (Fb)-liee	SiHF9530-E3	
SnPb	IRF9530	
SHED	SiHF9530	

ABSOLUTE MAXIMUM RATINGS ( $T_C$	= 25 °C, uni	ess otherwis	e noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	- 100	V	
Gate-Source Voltage			$V_{GS}$	± 20	7 v	
Continuous Drain Current	V at 10.V	T <sub>C</sub> = 25 °C	,	- 12	А	
Continuous Drain Current	V <sub>GS</sub> at - 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	- 8.2		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	- 48	1	
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	400	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	- 12	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	8.8	mJ	
Maximum Power Dissipation T <sub>C</sub> = 25 °C			P <sub>D</sub>	88	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>		
Manustina Taurus	0.00 1	0.00 140		10	lbf ⋅ in	
Mounting Torque	6-32 or M3 screw			1.1	N·m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 4.2 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 12 A (see fig. 12).
- c.  $I_{SD} \le$  12 A,  $dI/dt \le$  140 A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le$  175 °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.7		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	) V, I <sub>D</sub> = - 250 μA	- 100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = - 1 mA	-	- 0.10	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	' <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	Vo	<sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		100 V, V <sub>GS</sub> = 0 V	-	-	- 100	μΑ
Duris Os assessor Os Olata Basistana			V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	- 500	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>		I <sub>D</sub> = - 7.2 Ab	-	-	0.30	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = - \$	50 V, I <sub>D</sub> = - 7.2 A <sup>b</sup>	3.7	-	-	S
Dynamic					1	ı	
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,	-	860	-	
Output Capacitance	C <sub>oss</sub>		<sub>DS</sub> = - 25 V, MHz, see fig. 5	-	340	-	pF
Reverse Transfer Capacitance	$C_{rss}$	1 = 1.0	IVIHZ, See lig. 5	-	93	-	
Total Gate Charge	$Q_g$				-	38	
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = - 10 V	$I_D = -12 \text{ A}, V_{DS} = -80 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	1	-	6.8	nC
Gate-Drain Charge	$Q_{gd}$	]	see lig. 0 and 10		-	21	
Turn-On Delay Time	t <sub>d(on)</sub>		'		12	-	ns
Rise Time	t <sub>r</sub>	$V_{DD} =  50 \text{ V}, I_D =  12 \text{ A},$ $R_g = 12 \ \Omega, R_D = 3.9 \ \Omega, \text{ see fig. } 10^b$		-	52	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			1	31	-	
Fall Time	t <sub>f</sub>			-	39	-	
Internal Drain Inductance	L <sub>D</sub>	, ,	Between lead, 6 mm (0.25") from package and center of die contact		4.5	-	-11
Internal Source Inductance	L <sub>S</sub>				7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 12	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	- 48	A
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = - 12 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	- 6.3	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>				120	240	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = -12  \text{A}, dI/dt = 100  \text{A/} \mu \text{s}^{\text{b}}$		-	0.46	0.92	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

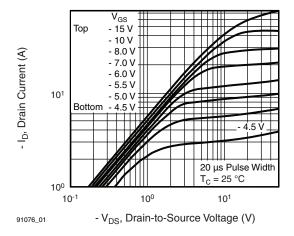


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

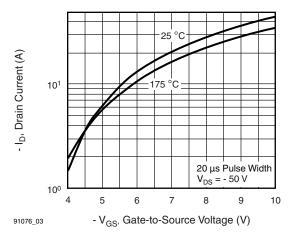


Fig. 3 - Typical Transfer Characteristics

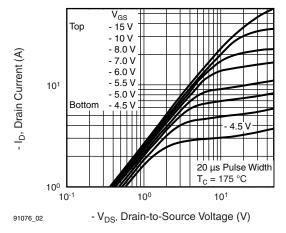


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 175 °C

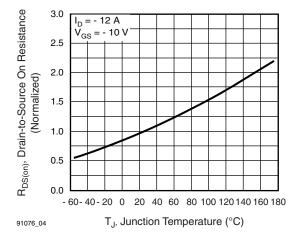


Fig. 4 - Normalized On-Resistance vs. Temperature



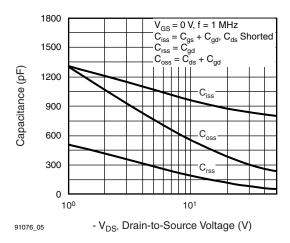


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

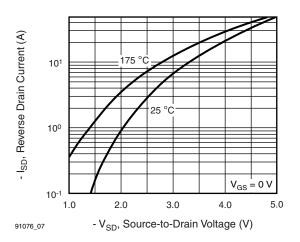


Fig. 7 - Typical Source-Drain Diode Forward Voltage

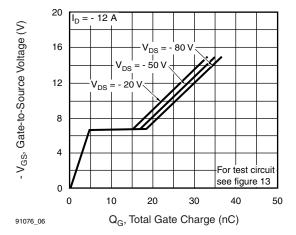


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

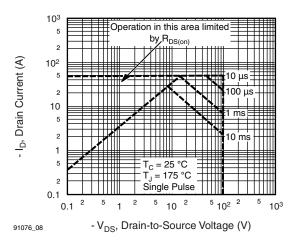


Fig. 8 - Maximum Safe Operating Area



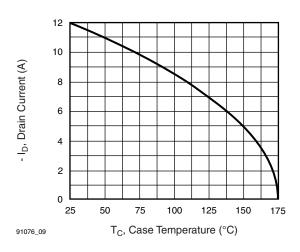


Fig. 9 - Maximum Drain Current vs. Case Temperature

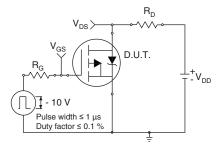


Fig. 10a - Switching Time Test Circuit

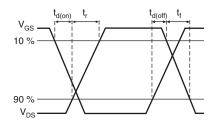


Fig. 10b - Switching Time Waveforms

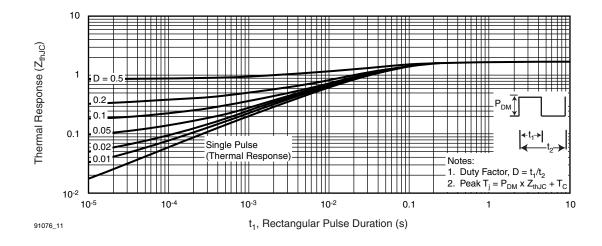


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



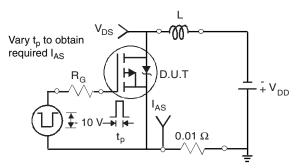


Fig. 12a - Unclamped Inductive Test Circuit

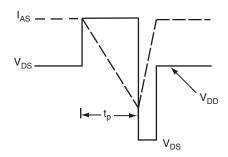


Fig. 12b - Unclamped Inductive Waveforms

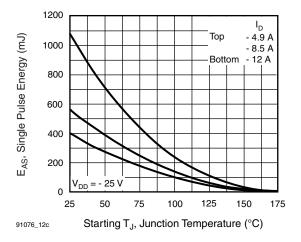


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

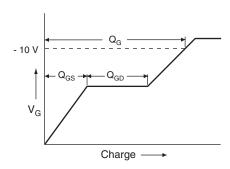


Fig. 13a - Basic Gate Charge Waveform

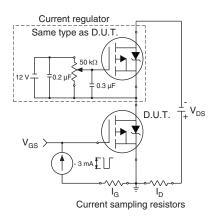
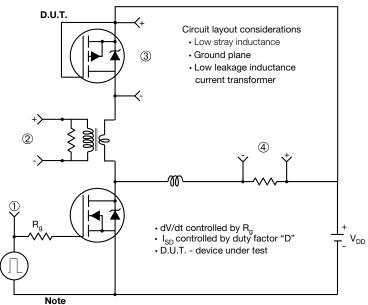


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

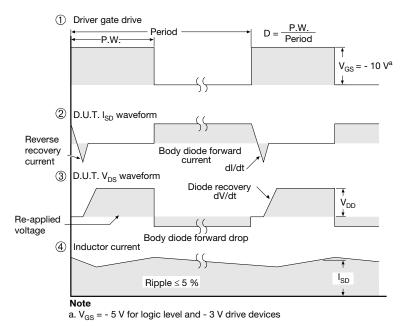
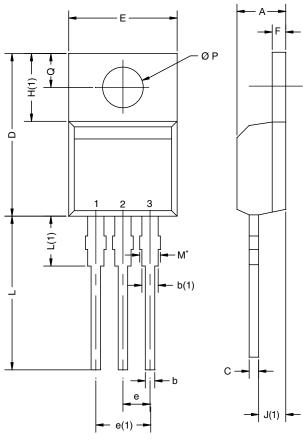


Fig. 14 - For P-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91076.



# **TO-220AB**



<del>-</del> e(	1) —	
		D2

	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
D2	12.19	12.70	0.480	0.500	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: T14-0413-Rev. P, 16-Jun-14 DWG: 5471					

#### Note

 $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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Revision: 02-Oct-12 Document Number: 91000